

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/534,421 CHEN ET AL.	
		Examiner	Art Unit Paul Marcantoni	1793 Page 1 of 1

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	V	JP 59045953 (Asahi Chemical) 3/15/84 abstract only.
	W	JP 2004051379 (Takahashi et al.) 2/19/2004 abstract only.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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